Search Notes

Application/Control No.					

Applicant(s)/Patent under Reexamination FUJII, TOSHIYA

09/093,271

Examiner

2611

Art Unit

Son P. Huynh

	SEARCHED				
Class	Subclass	Date	Examiner		
UPDATE	SEARCH	5/24/2005	АН		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
725	109-110	5/24/2005	AH		
725	112-113	5/24/2005	АН		
345	715,723	5/24/2005	АН		
715/719,784,785,500.1; 709/217-219; 725/39-61		5/24/2005	АН		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST TEXT SEARCH ENCLOSED	5/24/2005	АН	